

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination FUNAHASHI ET AL.	
		Examiner Devona E. Faulk	Art Unit 2644	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,259,798	07-2001	Perkins et al.	381/397
	B	US-6,686,036	02-2004	Tokura et al.	428/323
	C	US-5,621,804	04-1997	Beppu, Satoshi	381/332
	D	US-			
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	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	EP 800330 A2	10-1997	European Patent	FUNAHASHI et al.	H04R 01/28
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Applicant's admitted prior art , Figure 22, page 1, line 24-page 2, line 16.
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.